



**NSAI**  
Standards

Irish Standard  
I.S. EN ISO 25178-604:2013

Geometrical product specifications (GPS) -  
Surface texture: Areal - Part 604: Nominal  
characteristics of non-contact (coherence  
scanning interferometry) instruments  
(ISO 25178-604:2013)

## I.S. EN ISO 25178-604:2013

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English Version

**Geometrical product specifications (GPS) - Surface texture:  
Areal - Part 604: Nominal characteristics of non-contact  
(coherence scanning interferometry) instruments (ISO 25178-  
604:2013)**

Spécification géométrique des produits (GPS) - État de surface: Surfacique - Partie 604: Caractéristiques nominales des instruments sans contact (à interférométrie par balayage à cohérence) (ISO 25178-604:2013)

Geometrische Produktspezifikation (GPS) - Oberflächenbeschaffenheit: Flächenhaft - Teil 604: Merkmale von berührungslos messenden Geräten (der Kohärenz-Scannungs-Interferometrie) (ISO 25178-604:2013)

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**CEN-CENELEC Management Centre: Avenue Marnix 17, B-1000 Brussels**

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## **Foreword**

This document (EN ISO 25178-604:2013) has been prepared by Technical Committee ISO/TC 213 “Dimensional and geometrical product specifications and verification” in collaboration with Technical Committee CEN/TC 290 “Dimensional and geometrical product specification and verification” the secretariat of which is held by AFNOR.

This European Standard shall be given the status of a national standard, either by publication of an identical text or by endorsement, at the latest by February 2014, and conflicting national standards shall be withdrawn at the latest by February 2014.

Attention is drawn to the possibility that some of the elements of this document may be the subject of patent rights. CEN [and/or CENELEC] shall not be held responsible for identifying any or all such patent rights.

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STANDARD**

**ISO  
25178-604**

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**Geometrical product specifications  
(GPS) — Surface texture: Areal —**

Part 604:

**Nominal characteristics of non-  
contact (coherence scanning  
interferometry) instruments**

*Spécification géométrique des produits (GPS) — État de surface:  
Surfacique —*

*Partie 604: Caractéristiques nominales des instruments sans contact  
(à interférométrie par balayage à cohérence)*



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## Foreword

ISO (the International Organization for Standardization) is a worldwide federation of national standards bodies (ISO member bodies). The work of preparing International Standards is normally carried out through ISO technical committees. Each member body interested in a subject for which a technical committee has been established has the right to be represented on that committee. International organizations, governmental and non-governmental, in liaison with ISO, also take part in the work. ISO collaborates closely with the International Electrotechnical Commission (IEC) on all matters of electrotechnical standardization.

The procedures used to develop this document and those intended for its further maintenance are described in the ISO/IEC Directives, Part 1. In particular the different approval criteria needed for the different types of ISO documents should be noted. This document was drafted in accordance with the editorial rules of the ISO/IEC Directives, Part 2. [www.iso.org/directives](http://www.iso.org/directives)

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The committee responsible for this document is ISO/TC 213, *Dimensional and geometrical product specifications and verification*. The document was prepared in collaboration with Technical Committee CEN/TC 290, *Dimensional and geometrical product specifications and verification*.

ISO 25178 consists of the following parts, under the general title *Geometrical product specifications (GPS) — Surface texture: Areal*:

- Part 1: *Indication of surface texture*
- Part 2: *Terms, definitions and surface texture parameters*
- Part 3: *Specification operators*
- Part 6: *Classification of methods for measuring surface texture*
- Part 70: *Physical measurement standards*
- Part 71: *Software measurement standards*
- Part 601: *Nominal characteristics of contact (stylus) instruments*
- Part 602: *Nominal characteristics of non-contact (confocal chromatic probe) instruments*
- Part 603: *Nominal characteristics of non-contact (phase shifting interferometric microscopy) instruments*
- Part 604: *Nominal characteristics of non-contact (coherence scanning interferometry) instruments*
- Part 605: *Nominal characteristics of non-contact (point autofocus probe) instruments*
- Part 606: *Nominal characteristics of non-contact (focus variation) instruments*
- Part 701: *Calibration and measurement standards for contact (stylus) instruments*

The following part is under preparation:

- Part 72: *XML file format x3p*

## Introduction

This part of ISO 25178 is a geometrical product specification (GPS) standard and is to be regarded as a general GPS standard (see ISO/TR 14638). It influences chain link 5 of the chains of standards on roughness profile, waviness profile, primary profile and areal surface texture.

The ISO/GPS Masterplan given in ISO/TR 14638 gives an overview of the ISO/GPS system of which this document is a part. The fundamental rules of ISO/GPS given in ISO 8015 apply to this document and the default decision rules given in ISO 14253-1 apply to specifications made in accordance with this document, unless otherwise indicated.

For more detailed information on the relation of this part of ISO 25178 to other standards and to the GPS matrix model, see [Annex E](#).

This part of ISO 25178 describes the metrological characteristics of coherence scanning interferometric microscopes, designed for the measurement of surface topography maps. For more detailed information on the coherence scanning technique, see [Annex A](#) and [Annex B](#).

**NOTE** Portions of this document, particularly the informative texts, may describe patented systems and methods. This information is provided only to assist users in understanding the operating principles of coherence scanning interferometry. This document is not intended to establish priority for any intellectual property, nor does it imply a license to any proprietary technologies that may be described herein.



# Geometrical product specifications (GPS) — Surface texture: Areal —

## Part 604: Nominal characteristics of non-contact (coherence scanning interferometry) instruments

### 1 Scope

This part of ISO 25178 specifies the metrological characteristics of coherence scanning interferometry (CSI) systems for 3D mapping of surface height.

### 2 Terms and definitions

For the purposes of this document, the following terms and definitions apply.

#### 2.1 Terms and definitions related to all areal surface texture measurement methods

##### 2.1.1

##### **areal reference**

component of the instrument that generates a reference surface with respect to which the surface topography is measured

##### 2.1.2

##### **coordinate system of the instrument**

right hand orthonormal system of axes  $(x, y, z)$  defined as:

- $(x, y)$  is the plane established by the areal reference of the instrument (note that there are optical instruments that do not possess a physical areal guide)
- $z$ -axis is mounted parallel to the optical axis and is perpendicular to the  $(x, y)$  plane for an optical instrument; the  $z$ -axis is in the plane of the stylus trajectory and is perpendicular to the  $(x, y)$  plane for a stylus instrument (see [Figure 1](#))

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